

Application/Control No.	Applicant(s)/Patent under Reexamination
10/551,048	APFELBACHER ET AL.
Examiner	Art Unit
Hae M. Hyeon	2839

	SEARCHED					
Class	Subclass	Date	Examiner			
Search	Updated	10/01	hmh			

INT	ERFERENC	NCE SEARCHED		
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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